


<b>Search Notes</b>  	<b>Application/Control No.</b>  10520418	<b>Applicant(s)/Patent Under Reexamination</b>  SCHUETZE ET AL.
	<b>Examiner</b>  Sellman, Cachet I	<b>Art Unit</b>  1792

### SEARCHED

Class	Subclass	Date	Examiner
427	2.11, 289	10/12/2008	cis
435	4	10/12/2008	cis
436	174	10/12/2008	cis

### SEARCH NOTES

Search Notes	Date	Examiner
inventor search in East (see search history)	1/15/2008	
text search in East	1/15/2008	
text search in East	1/22/2008	
inventor search in Palm	10/12/2008	cis
text search in East	10/12/2008	cis
Google search (uv, ultra violet, absorb, microscope, ablat, cutting, sample, membrane, protective film)	10/12/2008	cis
updated search in East	5/15/2009	cis

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
427	2.11,289	5/15/2009	cis
436	174	5/15/2009	cis
435	40.5,40.52,4	5/15/2009	cis

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